Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,370	YEH ET AL.	
Examiner	Art Unit	
TRONG PHAN	2827	

SEARCHED					
Class	Subclass	Date	Examiner		
365	185.03	12/21/2005	TP		
	185.11	5/14/2006	TP		
	185.18				
	185.28				
	185.29				
	185.33				

INTERFERENCE SEARCHED				
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All above se	arch updated	5/14/2006	TP	

DATE 12/21/2005	EXMR
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